

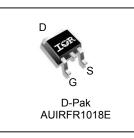
Features

- Advanced Process Technology
- Ultra Low On-Resistance
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *



HEXFET[®] Power MOSFET

V _{DSS}		60V
R _{DS(on)}	typ.	7.1mΩ
	max.	8.4mΩ
LD (Silicon Lim	iited)	79A ①
D (Package Li	mited)	56A



G	D	S
Gate	Drain	Source

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature,

fast switching speed and improved repetitive avalanche rating . These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

Base part number - Baskana Tura		Standard Pack		Orderable Part Number
Base part number	Package Type	Form	Quantity	Orderable Part Number
		Tube	75	AUIRFR1018E
AUIRFR1018E	D-Pak	Tape and Reel Left	3000	AUIRFR1018ETRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	79 ①	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	56 ①	•
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	56	— A
I _{DM}	Pulsed Drain Current ②	315	
P _D @T _C = 25°C	Maximum Power Dissipation	110	W
	Linear Derating Factor	0.76	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS} Single Pulse Avalanche Energy (Thermally Limited) 3		88	mJ
I _{AR}	Avalanche Current ②	47	A
E _{AR}	Repetitive Avalanche Energy 2	11	mJ
dv/dt	Pead Diode Recovery dv/dt	21	V/ns
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

Symbol	Parameter	Тур.	Max.	Units
R _{θJC}	Junction-to-Case		1.32	
$R_{ ext{ heta}JA}$	Junction-to-Ambient (PCB Mount) ®		50	°C/W
$R_{ heta JA}$	Junction-to-Ambient ®		110	

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*Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	60		_	V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.073		V/°C	Reference to 25°C, I_D = 5mA $@$
R _{DS(on)}	Static Drain-to-Source On-Resistance		7.1	8.4	mΩ	V _{GS} = 10V, I _D = 47A ⑤
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$
gfs	Forward Trans conductance	110			S	V _{DS} = 50V, I _D = 47A
R _{G(Int)}	Internal Gate Resistance		0.73		Ω	
1	Drain-to-Source Leakage Current			20	μA	V _{DS} = 60V, V _{GS} = 0V
DSS				250	μΑ	V _{DS} = 48V,V _{GS} = 0V,T _J =125°C
1	Gate-to-Source Forward Leakage			100	5	V _{GS} = 20V
GSS	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q _g	Total Gate Charge	 46	69		I _D = 47A
Q _{gs}	Gate-to-Source Charge	 10		nC	V _{DS} = 30V
Q _{gd}	Gate-to-Drain Charge	 12			V _{GS} = 10V⑤
Q _{sync}	Total Gate Charge Sync. (Q _g - Q _{gd})	 34			
t _{d(on)}	Turn-On Delay Time	 13			V _{DD} = 39V
t _r	Rise Time	 35			I _D = 47A
t _{d(off)}	Turn-Off Delay Time	 55		ns	$R_{G} = 10\Omega$
t _f	Fall Time	 46			V _{GS} = 10V⑤
C _{iss}	Input Capacitance	 2290			V _{GS} = 0V
C _{oss}	Output Capacitance	 270			V _{DS} = 50V
C _{rss}	Reverse Transfer Capacitance	 130		pF	f = 1.0MHz
C _{oss eff.} (ER)	Effective Output Capacitance (Energy Related)	 390			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 48V \bigcirc$
C _{oss eff.} (TR)	Effective Output Capacitance (Time Related)	 630			V_{GS} = 0V, V_{DS} = 0V to 48V (6)
Diode Chara	octeristics				

	Parameter	Min.	Тур.	Max.	Units	Conditions
I _S	Continuous Source Current (Body Diode)			79 ①		MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			315		integral reverse
V_{SD}	Diode Forward Voltage			1.3	V	T _J = 25°C,I _S = 47A,V _{GS} = 0V ⑤
t _{rr}	Reverse Recovery Time		26	39		T _J = 25°C
			31	47	ns	$T_{\rm J} = 125^{\circ}C$ $V_{\rm R} = 51V$,
Q _{rr}	Reverse Recovery Charge		24	36	nC	T _J = 25°C I _F = 47A
			35	53		T _J = 125°C di/dt = 100A/µs ⑤
			1.8		Α	T _J = 25°C
t _{on}	Forward Turn-On Time	Intrinsic	Intrinsic turn-on time is negligible (turn-on is dominated by $L_{S}+L_{D}$)			

Notes:

- Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 56A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- $\$ Limited by T_{Jmax}, starting T_J = 25°C, L = 0.08mH, R_G = 25 Ω , I_{AS} = 47A, V_{GS} =10V. Part not recommended for use above this value.
- $\label{eq:ISD} \textcircled{0.5mu}{0.5mu} I_{SD} \leq 47A, \, di/dt \leq 1668A/\mu s, \, V_{DD} \leq V_{(BR)DSS}, \, T_J \leq 175^{\circ}C.$
- 6 C_{oss eff}. (TR) is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- \odot C_{oss eff.} (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994
- (9) R_{θ} is measured at T_J approximately 90°C.



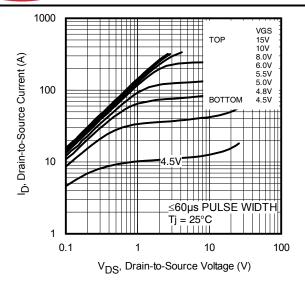


Fig. 1 Typical Output Characteristics

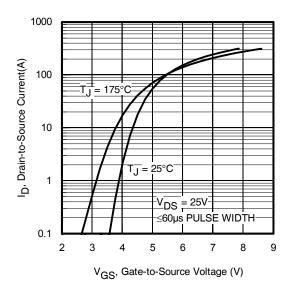


Fig. 3 Typical Transfer Characteristics

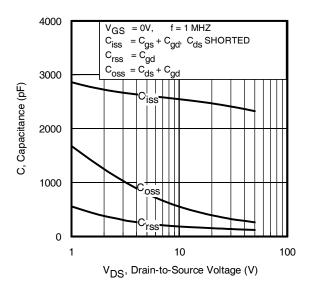


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

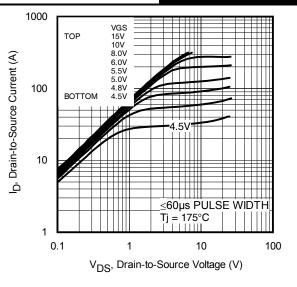


Fig. 2 Typical Output Characteristics

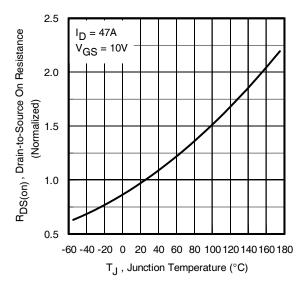


Fig. 4 Normalized On-Resistance vs. Temperature

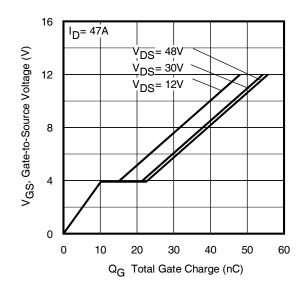


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage



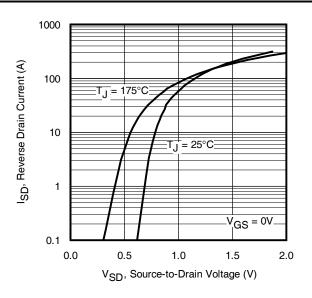


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

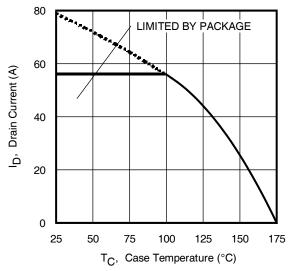


Fig. 9 Maximum Drain Current vs. Case Temperature

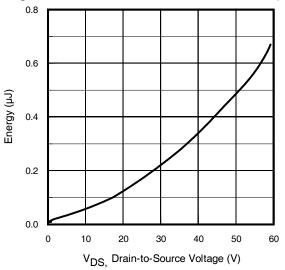
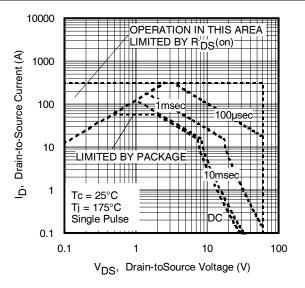
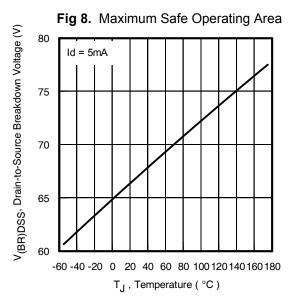


Fig. 11 Typical Coss Stored Energy







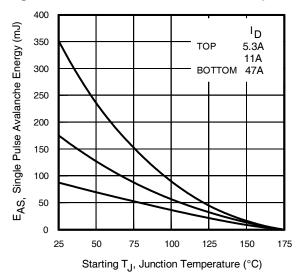
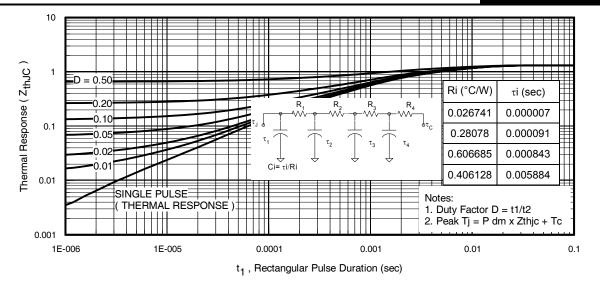


Fig 12. Maximum Avalanche Energy vs. Drain Current







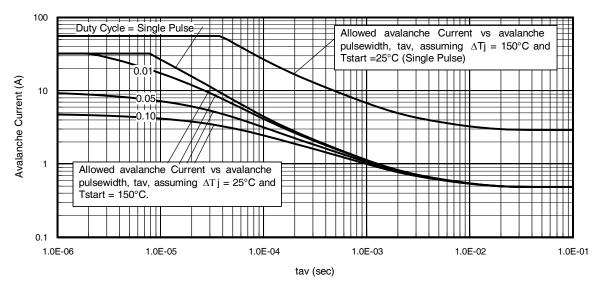


Fig 14. Typical Avalanche Current Vs. Pulse width

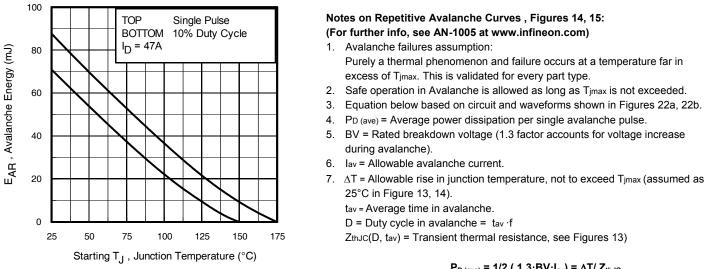
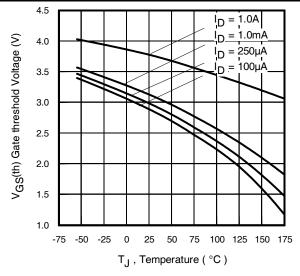


Fig 15. Maximum Avalanche Energy Vs. Temperature

$$\begin{split} \textbf{P}_{D (ave)} &= 1/2 \text{ (} 1.3 \cdot \textbf{BV} \cdot \textbf{I}_{av} \text{)} = \Delta T / \textbf{Z}_{thJC} \\ \textbf{I}_{av} &= 2\Delta T / [1.3 \cdot \textbf{BV} \cdot \textbf{Z}_{th}] \\ \textbf{E}_{AS (AR)} &= \textbf{P}_{D (ave)} \cdot \textbf{t}_{av} \end{split}$$







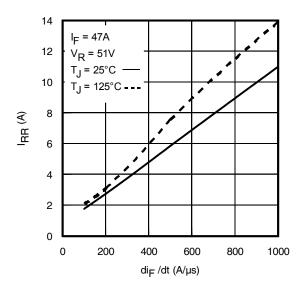


Fig. 18 - Typical Recovery Current vs. dif/dt

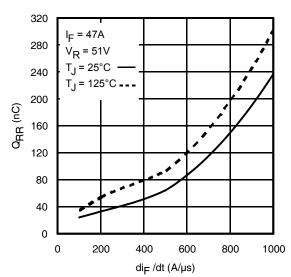


Fig. 20 - Typical Stored Charge vs. dif/dt

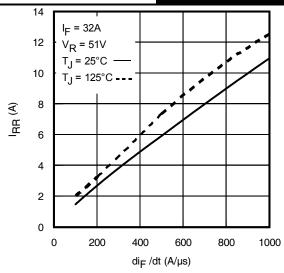


Fig. 17 - Typical Recovery Current vs. dif/dt

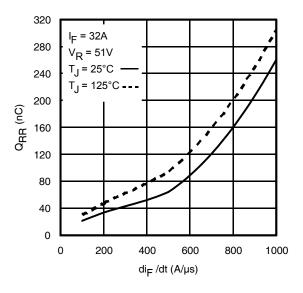


Fig. 19 - Typical Stored Charge vs. dif/dt



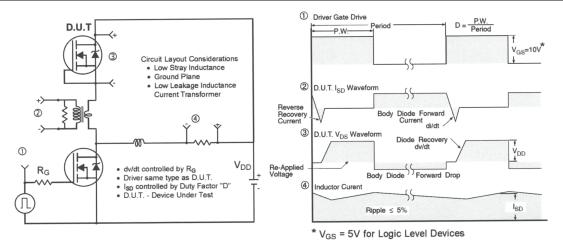


Fig 20. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

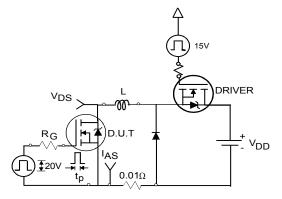


Fig 21a. Unclamped Inductive Test Circuit

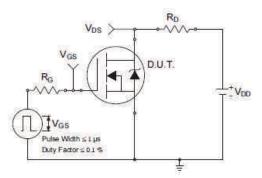


Fig 22a. Switching Time Test Circuit

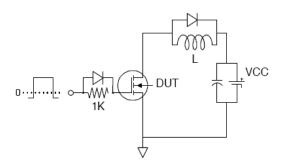


Fig 23a. Gate Charge Test Circuit

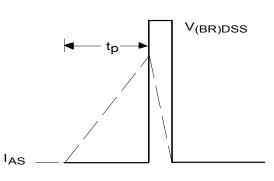


Fig 21b. Unclamped Inductive Waveforms

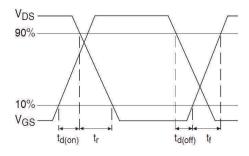


Fig 22b. Switching Time Waveforms

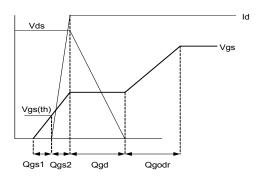
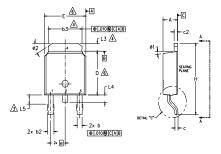


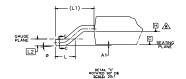
Fig 23b. Gate Charge Waveform

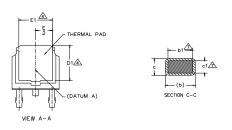


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- A- LEAD DIMENSION UNCONTROLLED IN 15.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.- SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- ▲ DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION 61 & c1 APPLIED TO BASE METAL ONLY.
- $\underline{\&}$ DATUM A & B TO BE DETERMINED AT DATUM PLANE H. 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

S					
S Y M			N		
B O	MILLIM	MILLIMETERS INCHES			0 T E S
L	MIN.	MAX.	MIN.	MAX.	S
А	2.18	2.39	.086	.094	
A1	-	0.13	-	.005	
b	0.64	0.89	.025	.035	
ь1	0.65	0.79	.025	.031	7
b2	0.76	1.14	.030	.045	
b3	4.95	5.46	.195	.215	4
с	0.46	0.61	.018	.024	
c1	0.41	0.56	.016	.022	7
c2	0.46	0.89	.018	.035	
D	5.97	6.22	.235	.245	6
D1	5.21	-	.205	-	4
Е	6.35	6.73	.250	.265	6
E1	4.32	-	.170	-	4
е	2.29	BSC	.090	BSC	
н	9.40	10.41	.370	.410	
L	1.40	1.78	.055	.070	
L1	2.74	BSC	.108	REF.	
L2	0.51	BSC	.020	BSC	
L3	0.89	1.27	.035	.050	4
L4	-	1.02	-	.040	
L5	1.14	1.52	.045	.060	3
ø	0.	10 °	0.	10°	
ø1	0.	15 °	0.	15°	
ø2	25'	35*	25*	35*	

LEAD ASSIGNMENTS

<u>HEXFET</u>

1.- GATE 2.- DRAIN 3.- SOURCE 4.- DRAIN

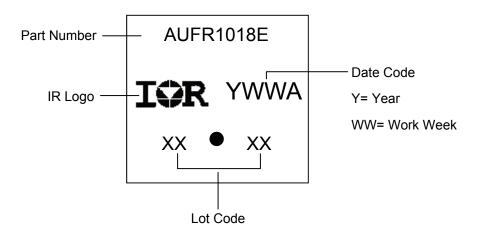
IGBT & CoPAK

1.- GATE

2.- COLLECTOR 3.- EMITTER

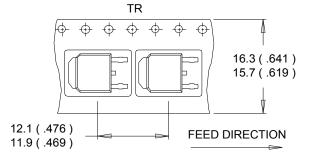
4.- COLLECTOR

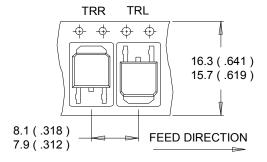
D-Pak (TO-252AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

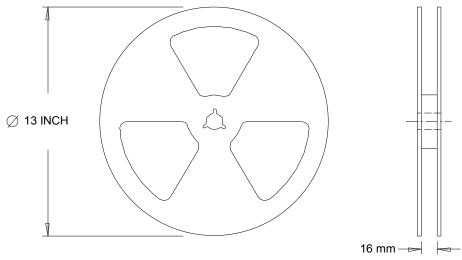
D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))





NOTES :

- 1. CONTROLLING DIMENSION : MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

			Automotive			
		(per AEC-Q101)				
		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moisture	Sensitivity Level	D-Pak MSL1				
			Class M4 (+/- 600V) [†]			
	Machine Model	AEC-Q101-002				
	Liuman Dadu Madal		Class H1C (+/- 1500V) [†]			
ESD	Human Body Model	AEC-Q101-001				
			Class C4 (+/- 1000V) [†]			
Charged Device Model		AEC-Q101-005				
RoHS Cor	RoHS Compliant Yes		Yes			

† Highest passing voltage.

Revision History

Date	Comments
11/19/2015	 Updated datasheet with corporate template Corrected ordering table on page 1. Corrected typo on test condition Coss eff. V_{DS} from "60V" to "48V" on page 2.
	 Updated typo on the fig.19 and fig.20, unit of y-axis from "A" to "nC" on page 6.

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